NDF10N62Z, NDP10N62Z

N-Channel Power MOSFET 620 V, 0.65 Ω

Features

- Low ON Resistance
- Low Gate Charge
- Zener Diode-protected Gate
- 100% Avalanche Tested
- These Devices are Pb-Free and RoHS Compliant

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Rating	Symbol	NDF10N62Z	NDP10N62Z	Unit
Drain-to-Source Voltage	V_{DSS}	620 (Note 1)		V
Continuous Drain Current, $R_{\theta JC}$	I _D	10 (N	10 (Note 2)	
Continuous Drain Current R _{0JC} , T _A = 100°C	I _D	5.7 (N	5.7 (Note 2)	
Pulsed Drain Current, V _{GS} @ 10 V	I _{DM}	36 (Note 2)		Α
Power Dissipation, R _{θJC} (Note 1)	P _D	36	125	W
Gate-to-Source Voltage	V _{GS}	±	30	V
Single Pulse Avalanche Energy, I _D = 10 A	E _{AS}	300		mJ
ESD (HBM) (JESD22-A114)	V _{esd}	3900		V
RMS Isolation Voltage (t = 0.3 sec., R.H. \leq 30%, T _A = 25°C) (Figure 14)	V _{ISO}	4500		V
Peak Diode Recovery	dv/dt	4.5 (Note 3)		V/ns
Continuous Source Current (Body Diode)	Is	10		Α
Maximum Temperature for Soldering Leads	TL	260		°C
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to 150		°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

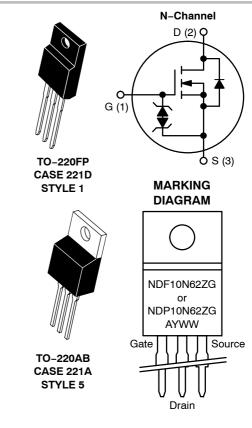
- Surface mounted on FR4 board using 1" sq. pad size, (Cu area = 1.127 in sq [2 oz] including traces)
- 2. Limited by maximum junction temperature
- 3. $I_S \leq$ 10 A, di/dt \leq 200 A/ μ s, V_{DD} = 80% BV $_{DSS}$



ON Semiconductor®

http://onsemi.com

V _{DSS}	R _{DS(ON)} (TYP) @ 5 A
620 V	0.65 Ω



A = Location Code
 Y = Year
 WW = Work Week
 G = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping
NDF10N62ZG	TO-220FP	50 Units/Rail
NDP10N62ZG	TO-220AB	In Development

THERMAL RESISTANCE

Parameter	Symbol	NDF10N62Z	NDP10N62Z	Unit
Junction-to-Case (Drain)		3.4	1.0	°C/W
Junction-to-Ambient Steady State (Note 4)		50	50	

Characteristic	Test Conditions		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS					•		
Drain-to-Source Breakdown Voltage	$V_{GS} = 0 \text{ V, I}_{D} = 1 \text{ mA}$	1	BV _{DSS}	620			V
Breakdown Voltage Temperature Coefficient	Reference to 25°C, I _D = 1 mA		$\Delta BV_{DSS}/ \ \Delta T_{J}$		0.6		V/°C
Drain-to-Source Leakage Current	25		I _{DSS}			1	μΑ
	V _{DS} = 620 V, V _{GS} = 0 V	125°C				50	
Gate-to-Source Forward Leakage	V _{GS} = ±20 V		I _{GSS}			±10	μА
ON CHARACTERISTICS (Note 5)					•		•
Static Drain-to-Source On-Resistance	V _{GS} = 10 V, I _D = 5.0 /	A	R _{DS(on)}		0.65	0.75	Ω
Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 100 μ	А	V _{GS(th)}	3.0		4.5	V
Forward Transconductance	V _{DS} = 15 V, I _D = 10 A		9FS		7.9		S
DYNAMIC CHARACTERISTICS	•				•		
Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz		C _{iss}		1425		pF
Output Capacitance			C _{oss}		150		
Reverse Transfer Capacitance			C _{rss}		35		
Total Gate Charge			Q_g		47		nC
Gate-to-Source Charge	V _{DD} = 310 V, I _D = 10 <i>i</i>	۹,	Q_{gs}		9.3		
Gate-to-Drain ("Miller") Charge	V _{GS} = 10 V		Q_{gd}		25		
Plateau Voltage					6.4		V
Gate Resistance			R_{g}		1.5		Ω
RESISTIVE SWITCHING CHARACTER	ISTICS						
Turn-On Delay Time			t _{d(on)}		15		ns
Rise Time	V _{DD} = 310 V, I _D = 10 <i>i</i>	Α,	t _r		31		1
Turn-Off Delay Time	V_{GS} = 10 V, R_{G} = 5 Ω		t _{d(off)}		40		1
Fall Time			t _f		21		<u> </u>
SOURCE-DRAIN DIODE CHARACTER	RISTICS (T _C = 25°C unless oth	erwise not	ed)				
Diode Forward Voltage	I _S = 10 A, V _{GS} = 0 V	,	V _{SD}			1.6	V
Reverse Recovery Time	V _{GS} = 0 V, V _{DD} = 30 '	v	t _{rr}		395		ns
Reverse Recovery Charge	$I_S = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$		Q _{rr}		3.0		μС

^{4.} Insertion mounted

^{5.} Pulse Width \leq 380 $\mu s,$ Duty Cycle \leq 2%.

TYPICAL CHARACTERISTICS

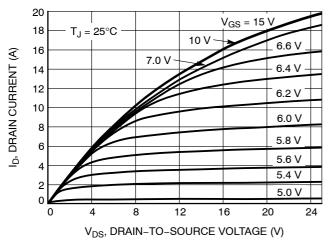


Figure 1. On-Region Characteristics

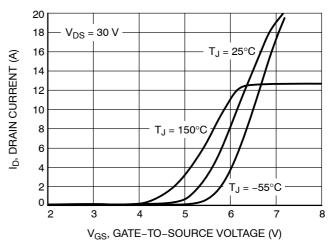


Figure 2. Transfer Characteristics

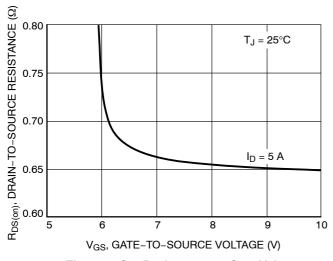


Figure 3. On-Resistance vs. Gate Voltage

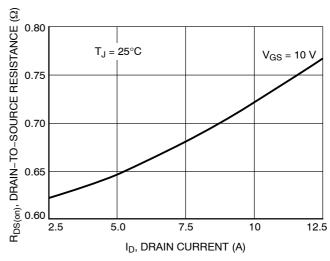


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

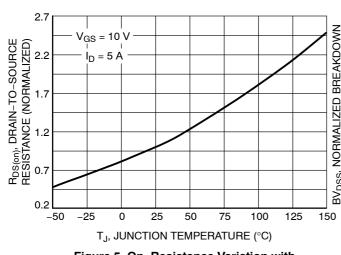


Figure 5. On–Resistance Variation with Temperature

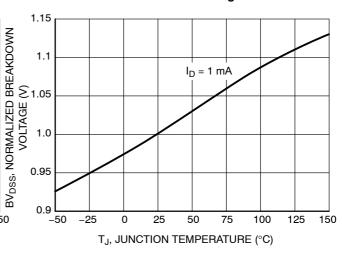


Figure 6. BVDSS Variation with Temperature

TYPICAL CHARACTERISTICS

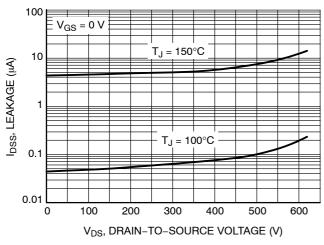


Figure 7. Drain-to-Source Leakage Current vs. Voltage

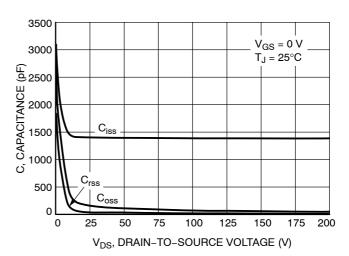


Figure 8. Capacitance Variation

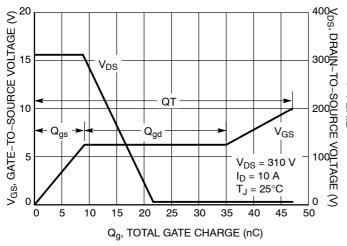


Figure 9. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

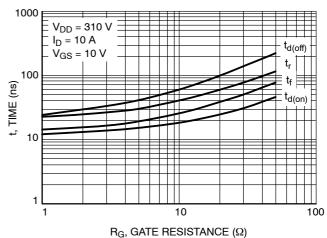


Figure 10. Resistive Switching Time Variation vs. Gate Resistance

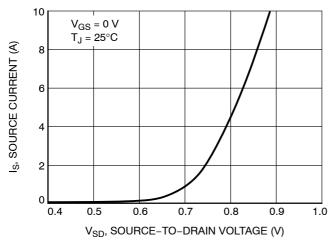


Figure 11. Diode Source Current vs. Forward Voltage

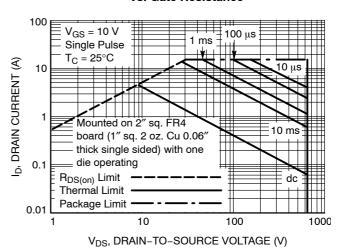


Figure 12. Maximum Rated Forward Biased Safe Operating Area for NDF10N62Z

TYPICAL CHARACTERISTICS

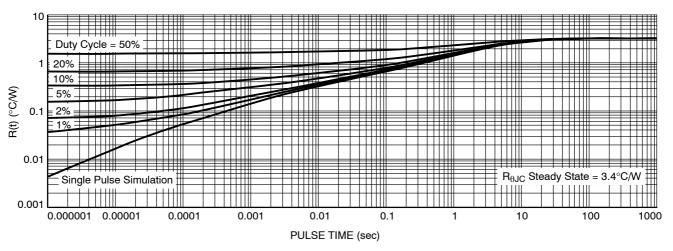


Figure 13. Thermal Impedance for NDF10N62Z

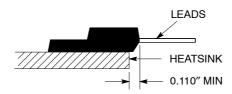


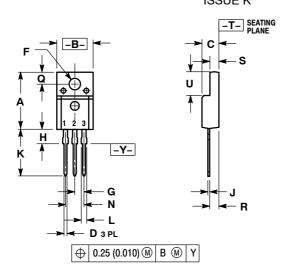
Figure 14. Isolation Test Diagram

Measurement made between leads and heatsink with all leads shorted together.

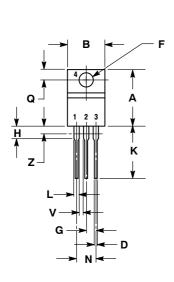
^{*}For additional mounting information, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

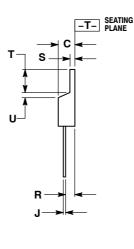
PACKAGE DIMENSIONS

TO-220FP CASE 221D-03 **ISSUE K**



TO-220AB CASE 221A-09 **ISSUE AE**





- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH
- 221D-01 THRU 221D-02 OBSOLETE, NEW STANDARD 221D-03

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.617	0.635	15.67	16.12
В	0.392	0.419	9.96	10.63
С	0.177	0.193	4.50	4.90
D	0.024	0.039	0.60	1.00
F	0.116	0.129	2.95	3.28
G	0.100	BSC	2.54	BSC
Н	0.118	0.135	3.00	3.43
J	0.018	0.025	0.45	0.63
K	0.503	0.541	12.78	13.73
L	0.048	0.058	1.23	1.47
N	0.200 BSC		5.08 BSC	
Q	0.122	0.138	3.10	3.50
R	0.099	0.117	2.51	2.96
S	0.092	0.113	2.34	2.87
U	0.239	0.271	6.06	6.88

PIN 1. GATE

2. DRAIN

SOURCE

NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: INCH.
- DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.570	0.620	14.48	15.75	
В	0.380	0.405	9.66	10.28	
С	0.160	0.190	4.07	4.82	
D	0.025	0.035	0.64	0.88	
F	0.142	0.161	3.61	4.09	
G	0.095	0.105	2.42	2.66	
Н	0.110	0.155	2.80	3.93	
J	0.014	0.025	0.36	0.64	
K	0.500	0.562	12.70	14.27	
L	0.045	0.060	1.15	1.52	
N	0.190	0.210	4.83	5.33	
Q	0.100	0.120	2.54	3.04	
R	0.080	0.110	2.04	2.79	
S	0.045	0.055	1.15	1.39	
T	0.235	0.255	5.97	6.47	
U	0.000	0.050	0.00	1.27	
٧	0.045		1.15		
Z		0.080		2.04	

STYLE 5:

PIN 1. GATE

DRAIN 3. SOURCE

DRAIN

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